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09/460,638	12/14/1999	KENNETH G. FLUGAUR	0325.00324	2751	
21363 75	590 08/11/2006		EXAMINER		
CHRISTOPHER P. MAIORANA, P.C.			ZERVIGON, RUDY		
24840 HARPER SUITE 100 ST. CLAIR SHORES, MI 48080			ART UNIT	PAPER NUMBER	
	•		1763	1763	
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Please find below and/or attached an Office communication concerning this application or proceeding.

		Application No.	Applicant(s)
		09/460,638	FLUGAUR ET AL.
	Office Action Summary	Examiner	Art Unit
		Rudy Zervigon	1763
Period fo	The MAILING DATE of this communication app or Reply	ears on the cover sheet with the c	orrespondence address
A SHI WHIC - Exter after - If NO - Failu Any r	ORTENED STATUTORY PERIOD FOR REPLY CHEVER IS LONGER, FROM THE MAILING DATE as a sign of time may be available under the provisions of 37 CFR 1.13 SIX (6) MONTHS from the mailing date of this communication. Period for reply is specified above, the maximum statutory period were to reply within the set or extended period for reply will, by statute, reply received by the Office later than three months after the mailing and patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be time will apply and will expire SIX (6) MONTHS from a cause the application to become ABANDONE	I. hely filed the mailing date of this communication. D (35 U.S.C. § 133).
Status	, , , , , , , , , , , , , , , , , , , ,		•
2a)⊠	Responsive to communication(s) filed on 30 M. This action is FINAL . 2b) This Since this application is in condition for allower closed in accordance with the practice under E	action is non-final.	
Dispositi	on of Claims		
5)□ 6)⊠ 7)□ 8)□ Applicati	Claim(s) 1-20 is/are pending in the application. 4a) Of the above claim(s) is/are withdraw Claim(s) is/are allowed. Claim(s) 1-20 is/are rejected. Claim(s) is/are objected to. Claim(s) are subject to restriction and/or on Papers	vn from consideration. r election requirement.	
10)	The specification is objected to by the Examine The drawing(s) filed on is/are: a) access applicant may not request that any objection to the Replacement drawing sheet(s) including the correct The oath or declaration is objected to by the Ex	epted or b) objected to by the Eddrawing(s) be held in abeyance. See ion is required if the drawing(s) is obj	e 37 CFR 1.85(a). ected to. See 37 CFR 1.121(d).
Priority u	nder 35 U.S.C. § 119		
a)[Acknowledgment is made of a claim for foreign All b) Some * c) None of: 1. Certified copies of the priority documents 2. Certified copies of the priority documents 3. Copies of the certified copies of the prior application from the International Bureau see the attached detailed Office action for a list of	s have been received. s have been received in Application ity documents have been receive (PCT Rule 17.2(a)).	on No ed in this National Stage
2) Notice 3) Inform	e of References Cited (PTO-892) e of Draftsperson's Patent Drawing Review (PTO-948) nation Disclosure Statement(s) (PTO-1449 or PTO/SB/08) r No(s)/Mail Date	4) Interview Summary Paper No(s)/Mail Da 5) Notice of Informal P 6) Other:	

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DETAILED ACTION

Claim Rejections - 35 USC § 103

1. The text of those sections of Title 35, U.S. Code not included in this action can be found in a prior Office action.

2. Claims 1-20 are rejected under 35 U.S.C. 103(a) as being unpatentable over Foster et al

(USPat. 5,665,640) in view of Ishikawa et al (USPat. 6,143,078) and Bernard J. Curtis (USPat.

4,328,068). Foster teaches a channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-

272 and conduit 256; Figure 2B; col. 18, lines 33-59) for a plasma processing chamber (item 40;

Figure 2) comprising: a one-piece outer portion (item 271; Figure 2B; col. 18 lines 33-59)

configured for insertion into an aperture¹ ("within cylinder 238"; col. 18, line 53) through a wall

(232; Figure 4B) of a plasma processing chamber (item 40; Figure 2), said one-piece outer

portion (item 271; Figure 2B; col. 18 lines 33-59) consisting an electrically insulative material

(271; "ceramic insulator"; col. 18 lines 42-43) and having dimensions effective to prevent or

inhibit plasma (col. 18, lines 33-58) arcing (col. 18 lines 50-58) to an electrically conductive

surface (232; Figure 2B - "metal housing 42"; column 17, lines 20-21, lines 50-55) of said wall

(232; Figure 4B) of said plasma processing chamber (item 40; Figure 2) exposed by said aperture

("within cylinder 238"; col. 18, line 53) through said wall (232; Figure 4B) of said plasma

processing chamber (item 40; Figure 2) said one-piece outer portion (item 271; Figure 2B; col.

18 lines 33-59) further comprising – claim 1

Foster further teaches:

¹ The Examiner agrees with Applicant's dictionary definition of "aperture" (Page 14, 1st paragraph of 2/13/6 reply), in this action and throughout the prosecution history.

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- i. a lower section (portion 270/271/256; Figure 2B) having a shape and dimension approximately the same as a corresponding shape and dimension² of said aperture ("within cylinder 238"; col. 18, line 53) wherein said lower section is configured to fit securely into said aperture ("within cylinder 238"; col. 18, line 53); and (iii) an inner opening (item 256;Fig.2B; col. 18, lines 33-58) communicating through the electrically insulative material (271; "ceramic insulator"; col. 18 lines 42-43) between a bottom and a top of the outer portion (271) claim 1, 5, 6, 8
- ii. A plasma processing chamber (item 40; Figure 2) having: at least one aperture ("within cylinder 238"; col. 18, line 53) therein, the at least one aperture ("within cylinder 238"; col. 18, line 53) having an exposed electrically conductive surface (232; Figure 2B "metal housing 42"; column 17, lines 20-21, lines 50-55), and the channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-272 and conduit 256; Figure 2B; col. 18, lines 33-59) for a plasma processing chamber (item 40; Figure 2) of Claim 1, inserted into the at least one aperture ("within cylinder 238"; col. 18, line 53), as claimed by claim 2
- iii. A method of making a plasma processing chamber (item 40; Figure 2), the chamber (item 40; Figure 2) having at least one aperture ("within cylinder 238"; col. 18, line 53) therein, the at least one aperture ("within cylinder 238"; col. 18, line 53) having an exposed electrically conductive surface (232; Figure 2B "metal housing 42"; column 17, lines 20-21, lines 50-55), the method comprising inserting (screws holding plates 272,239; Fig.

² Proportions of features in a drawing are not evidence of actual proportions when drawings are not to scale. Because the reference does not disclose that the drawings are to scale and is silent as to dimensions, arguments based on measurement of the drawing features are of little value. However, the description of the article pictured can

2B) the channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-272 and conduit 256; Figure 2B; col. 18, lines 33-59) for a plasma processing chamber (item 40; Figure 2) of Claim 1 into the <u>at least one</u> aperture ("within cylinder 238"; col. 18, line 53), as claimed by claim 3

- iv. A plasma processing chamber (item 40; Figure 2) having: a wall (232; Figure 4B); at least one aperture ("within cylinder 238"; col. 18, line 53) through said wall (232; Figure 4B), the at least one aperture ("within cylinder 238"; col. 18, line 53) having wall (232; Figure 4B), and an exposed electrically conductive surface (232; Figure 2B "metal housing 42"; column 17, lines 20-21, lines 50-55) of said wall (232; Figure 4B), and a one-piece sleeve (271; Figure 2B) configured for insertion into the aperture ("within cylinder 238"; col. 18, line 53), the one-piece sleeve (271; Figure 2B) consisting of an electrically insulative material (271; "ceramic insulator"; col. 18 lines 42-43) and having: dimensions effective to prevent inhibit plasma (col. 18, lines 33-58) arcing (col. 18 lines 50-58) to the exposed electrically conductive surface (232; Figure 2B "metal housing 42"; column 17, lines 20-21, lines 50-55) of the wall (232; Figure 4B) claim 5
- v. a lower section (portion 270/271/256; Figure 2B) having a shape approximate said aperture ("within cylinder 238"; col. 18, line 53) to fit into said aperture ("within cylinder 238"; col. 18, line 53); and an inner opening (item 256;Fig.2B; col. 18, lines 33-58) communicating through the electrically insulative material (271; "ceramic insulator"; col. 18 lines 42-43) from a bottom to a top of the one-piece sleeve (271; Figure 2B) claim 5

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vi. A method of making a plasma processing chamber (item 40; Figure 2) having a wall (232; Figure 4B), the method comprising: forming at least one aperture ("within cylinder 238"; col. 18, line 53) through said wall (232; Figure 4B), the at least one aperture ("within cylinder 238"; col. 18, line 53) having an exposed electrically conductive surface (232; Figure 2B - "metal housing 42"; column 17, lines 20-21, lines 50-55) of said wall (232; Figure 4B); and (B) inserting a one-piece sleeve (271; Figure 2B) into the aperture ("within cylinder 238"; col. 18, line 53), the one-piece sleeve (271; Figure 2B) consisting of an electrically insulative material (271; "ceramic insulator"; col. 18 lines 42-43) and having: dimensions effective to prevent or inhibit the exposed electrically conductive surface (232; Figure 2B - "metal housing 42"; column 17, lines 20-21, lines 50-55) of the plasma (col. 18, lines 33-58) arcing (col. 18 lines 50-58) to wall (232; Figure 4B) - claim 6

- vii. a lower section (portion 270/271/256; Figure 2B) having a shape approximate said aperture ("within cylinder 238"; col. 18, line 53) to fit into said aperture ("within cylinder 238"; col. 18, line 53); and (iv) an inner opening (item 256;Fig.2B; col. 18, lines 33-58) communicating through the electrically insulative material (271; "ceramic insulator"; col. 18 lines 42-43) between a bottom and a top of the one-piece sleeve (271; Figure 2B) claim 6
- viii. A method of processing a workpiece (228; Figure 2B; 48; Figure 2), comprising: (A) exposing the chamber (item 40; Figure 2) having (1) a wall (232; Figure 4B), (2) aperture ("within cylinder 238"; col. 18, line 53) having an exposed electrically conductive surface (232; Figure 2B "metal housing 42"; column 17, lines 20-21, lines 50-55) of

said wall (232; Figure 4B), and a one-piece sleeve (271; Figure 2B) inserted into the aperture ("within cylinder 238"; col. 18, line 53), the one-piece sleeve (271; Figure 2B) consisting of an electrically insulative material (271; "ceramic insulator"; col. 18 lines 42-43) and having: dimensions effective to prevent or inhibit plasma (col. 18, lines 33-58) arcing (col. 18 lines 50-58) to the exposed electrically conductive surface (232; Figure 2B - "metal housing 42"; column 17, lines 20-21, lines 50-55) of the wall (232; Figure 4B), (iii) a lower section (portion 270/271/256; Figure 2B) having a shape approximate a width (diameter) of said aperture ("within cylinder 238"; col. 18, line 53) to into said aperture ("within cylinder 238"; col. 18, line 53); and an inner opening (item 256;Fig.2B; col. 18, lines 33-58) communicating through the electrically insulative material (271; "ceramic insulator"; col. 18 lines 42-43) between a bottom and a top of the one-piece sleeve (271; Figure 2B) – claim 8

ix. A method of operating a plasma processing chamber (item 40; Figure 2), wherein the chamber (item 40; Figure 2) has at least one aperture ("within cylinder 238"; col. 18, line 53) therein and the aperture ("within cylinder 238"; col. 18, line 53) has an exposed electrically conductive surface (232; Figure 2B - "metal housing 42"; column 17, lines 20-21, lines 50-55), the method comprising the steps of: (A) initiating a plasma in the chamber (item 40; Figure 2), the aperture ("within cylinder 238"; col. 18, line 53) having the channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-272 and conduit 256; Figure 2B; col. 18, lines 33-59) for a plasma processing chamber (item 40; Figure 2) of Claim 1 therein, then (B) cleaning (col.30; line 14) the chamber (item 40; Figure 2) and the channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-272 and conduit

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- 256; Figure 2B; col. 18, lines 33-59) for a plasma processing chamber (item 40; Figure 2), as claimed by claim 9
- x. The method of Claim wherein said plasma exists in said chamber (item 40; Figure 2) for a predetermined period of time (col. 3, lines 1-7), as claimed by claim 10
- xi. The channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-272 and conduit 256; Figure 2B; col. 18, lines 33-59) for a plasma processing chamber (item 40; Figure 2) according to claim 1 wherein an outer surface (vertical surface) of said channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-272 and conduit 256; Figure 2B; col. 18, lines 33-59) for a plasma processing chamber (item 40; Figure 2) forms an angle with reference to the bottom (horizontal surface) of said channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-272 and conduit 256; Figure 2B; col. 18, lines 33-59) for a plasma processing chamber (item 40; Figure 2), as claimed by claim 16
- The channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-272 and conduit 256; Figure 2B; col. 18, lines 33-59) for a plasma processing chamber (item 40; Figure 2) according to claim 1, wherein the electrically insulative material (271; "ceramic insulator"; col. 18 lines 42-43) is selected from the group consisting of ceramics, multicrystal ceramics, polyvinyl polymers, polytetrafluoroethylene, polyethylene, polypropylene, polyimides, polycarbonates and single crystal insulative minerals, as claimed by claim 20

Foster does not teach:

i. wherein said inner opening (item 256;Fig.2B; col. 18, lines 33-58) transfers a spectroscopic endpoint detection signal – claim 1, 5, 6, 8

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ii. said one-piece outer portion (item 271; Figure 2B; col. 18 lines 33-59) further comprising a flange section having a dimension² greater than a corresponding dimension of siad aperture³ ("within cylinder 238"; col. 18, line 53), such that said flange section contacts a portion of an outside surface of said wall surrounding said aperture ("within cylinder 238"; col. 18, line 53) when said channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-272 and conduit 256; Figure 2B; col. 18, lines 33-59) is inserted in said aperture⁴ ("within cylinder 238"; col. 18, line 53) through said wall (232; Figure 4B) of said plasma processing chamber (item 40; Figure 2) – claim 1

iii. A method of processing a workpiece (228; Figure 2B; 48; Figure 2), comprising the following steps: (A) exposing the workpiece (228; Figure 2B; 48; Figure 2) to a plasma in the plasma processing chamber (item 40; Figure 2) of Claim 2 and (B) transmitting the spectroscopic endpoint detection signal ("RF"; col. 18, line 54) through the channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-272 and conduit 256; Figure 2B; col. 18, lines 33-59) for a plasma processing chamber (item 40; Figure 2) out from the plasma processing chamber (item 40; Figure 2), as claimed by claim 4 – The Examiner believes that the directionality (into or out of Foster's chamber) of Foster's signal is a claim requirement of intended use. The Examiner believes Foster's apparatus is inherently capable of performing the intended use. It is well established that apparatus claims must be structurally distinguished from the prior art (In re Danley, 120 USPQ 528, 531 (CCPA 1959). — When the structure recited in the references is substantially

³ The Examiner agrees with Applicant's dictionary definition of "aperture" (Page 14, 1st paragraph of 2/13/6 reply), in this action and throughout the prosecution history.

⁴ The Examiner agrees with Applicant's dictionary definition of "aperture" (Page 14, 1st paragraph of 2/13/6 reply), in this action and throughout the prosecution history.

identical to that of the claims, claimed properties or functions are presumed to be inherent. MPEP 2112.01

- iv. a flange section having a dimension greater than a corresponding dimension of said aperture⁵ ("within cylinder 238"; col. 18, line 53), such that said flange section contacts a portion of an outside surface of said wall surrounding said aperture ("within cylinder 238"; col. 18, line 53) when said (one-piece) sleeve is inserted in said aperture claim 5, 6, 8
- v. The method of Claim 6, further comprising, prior to inserting said one-piece sleeve (271; Figure 2B), the step of forming said bottom of said one-piece sleeve (271; Figure 2B) to a plane having a non-orthogonal angle relative to said inner opening (item 256; Fig. 2B; col. 18, lines 33-58), as claimed by claim 7
- vi. transmitting a signal ("RF"; col. 18, line 54) through the one-piece sleeve (271; Figure 2B) out from the chamber (item 40; Figure 2) claim 8. See above argument for claim 4,
- vii. The channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-272 and conduit 256; Figure 2B; col. 18, lines 33-59) for a plasma processing chamber (item 40; Figure 2) according to claim 1, wherein said flange section has a width (diameter) that is greater than a corresponding width (diameter) of said aperture ("within cylinder 238"; col. 18, line 53), as claimed by claim 12
- viii. The channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-272 and conduit 256; Figure 2B; col. 18, lines 33-59) for a plasma processing chamber (item 40; Figure 2)

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according to claim 12 wherein said channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-272 and conduit 256; Figure 2B; col. 18, lines 33-59) for a plasma processing chamber (item 40; Figure 2) applies a predetermined amount of pressure against an inner wall (232; Figure 4B) of said aperture ("within cylinder 238"; col. 18, line 53), as claimed by claim 13

- ix. The channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-272 and conduit 256; Figure 2B; col. 18, lines 33-59) for a plasma processing chamber (item 40; Figure 2) according to claim 12, wherein said lower section (portion 270/271/256; Figure 2B) has a first length and said flange section has a second length, as claimed by claim 14
- x. The channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-272 and conduit 256; Figure 2B; col. 18, lines 33-59) for a plasma processing chamber (item 40; Figure 2) according to claim 14, wherein said first length is greater than a length of said aperture ("within cylinder 238"; col. 18, line 53), as claimed by claim 15
- xi. The channel sleeve (item 58; Figure 2; col. 18 lines 33-59; items 270-272 and conduit 256; Figure 2B; col. 18, lines 33-59) for a plasma processing chamber (item 40; Figure 2) according to claim 16, wherein said angle is non-orthogonal, as claimed by claim 17

Ishikawa teaches a similar channel sleeve for a plasma processing chamber (302; Figure 5) used to deliver process gas to a treatment chamber (column 9, lines 45-64). Specifically, Ishikawa teaches a one-piece sleeve (outer surface of 302) with a flange section (302/314 interface) configured to remain outside the aperture.

⁵ The Examiner agrees with Applicant's dictionary definition of "aperture" (Page 14, 1st paragraph of 2/13/6 reply), in this action and throughout the prosecution history.

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Foster and Ishikawa do not teach a physical signal ("RF"; col. 18, line 54) from the channel sleeve for a plasma processing chamber (item 40; Figure 2) of claim 1 consisting of a spectroscopic endpoint detection signal or a channel therefore.

Bernard J. Curtis teaches a spectroscopic endpoint detection signal and a channel therefore (34,36,32; Figure 3; column 2, lines 59-68).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to construct Foster's one-piece sleeve to include a flange section configured to remain outside the aperture as taught by Ishikawa and to optimize the dimensions of the flange section, the lower section, and the bottom planar angle of Foster's one-piece sleeve, further, to replace Foster and Ishikawa's RF physical signal as discussed above with Bernard J. Curtis's spectroscopic endpoint detection signal.

Motivation to construct Foster's one-piece sleeve to include a flange section configured to remain outside the aperture as taught by Ishikawa and to optimize the dimensions of the flange section, the lower section, and the bottom planar angle of Foster's one-piece sleeve is to enhance hermeticity of the process chamber as taught by Ishikawa (column 10, lines 20-28). Further, it is well established that changes in apparatus dimensions are within the level of ordinary skill in the art.(Gardner v. TEC Systems, Inc., 725 F.2d 1338, 220 USPQ 777 (Fed. Cir. 1984), cert. denied, 469 U.S. 830, 225 USPQ 232 (1984); In re Rose, 220 F.2d 459, 105 USPQ 237 (CCPA 1955); In re Rinehart, 531 F.2d 1048, 189 USPQ 143 (CCPA 1976); See MPEP 2144.04).

Motivation to replace Foster and Ishikawa's RF physical signal as discussed above with Bernard J. Curtis's spectroscopic endpoint detection signal is for determining the end point of the plasma etching process as discussed by Bernard J. Curtis (column 1, line 67 - column 2, line 5).

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Response to Arguments

3. Applicant's arguments with respect to claims 1-20 have been considered but are moot in view of the new grounds of rejection.

Conclusion

4. Applicant's amendment necessitated the new grounds of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

5. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Examiner Rudy Zervigon whose telephone number is (571) 272-1442. The examiner can normally be reached on a Monday through Thursday schedule from 8am through 7pm. The official fax phone number for the 1763 art unit is (571) 273-8300. Any Inquiry of a general nature or relating to the status of this application or proceeding should be directed to the Chemical and Materials Engineering art unit receptionist at (571) 272-1700. If the examiner

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can not be reached please contact the examiner's supervisor, Parviz Hassanzadeh, at (571) 272-

1435.

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